

GRACE

SPECIFICATION

ROHS Compliant Parts

Customer : _____

Part Name : **ESD Suppressors**

Part Number : **KESD-E Size**

Dongguan GRACE electronic Technology Co., LTD

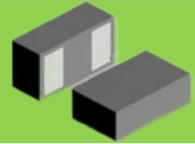
**Address: Songhu Information Industrial Park.GuanminTou,Chashan Town,
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Tel: 0769-22008861 Web: www.gracevn.com Email: grace@gracevn.com

Polymer ESD Suppressors — KESD - U series

For **ESD protection**

- **Ultra-low capacitance**



Features

- Excellent ESD clamping & Small Insertion Loss
- Operating temperature from -55 °C to 125°C
- High transient current capability, Fastest response time
- Capacitance is designed to ultra-low value, which can be efficiently suitable to high speed data line
- 100% Pb free, RoHS

Applications

- CMOS and MOSFET protection from ESD
- Computer ESD and I/O protection
- Telecommunication transient protection- USB2.0、3.0 port, IEEE-1394, RF module, Antenna circuit, high speed Protocol Etc.

Explanation of Part Numbers

KESD	0201	E	D	5R0	C0R05	A	K000	T
①	②	③	④	⑤	⑥	⑦	⑧	⑨

①	Series
GRACE Polymer ESD Suppressors	

②	Chip size (EIA)
0201	
0402	
0603	

③	Series code
E	Extra-low capacitance

④	Type of voltage
D	DC working voltage

⑤	Voltage values
5R0	5.0V
300	30V

⑥	Typical Capacitance @1MHZ
C0R05	0.05pF

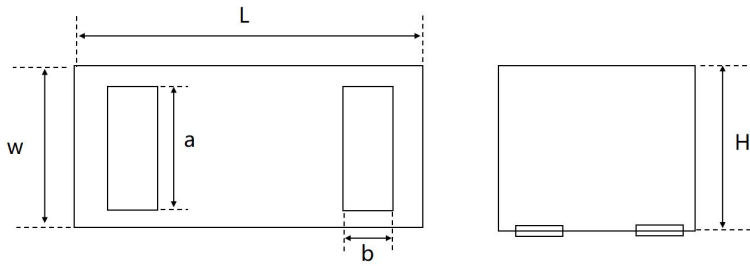
⑦	internal code
A	

⑧	Customer identification code
K000	

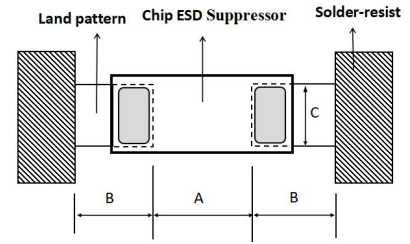
⑨	Packaging style
T	Tape
B	Bulk

■ Shape and Dimensions

1) Dimensions:



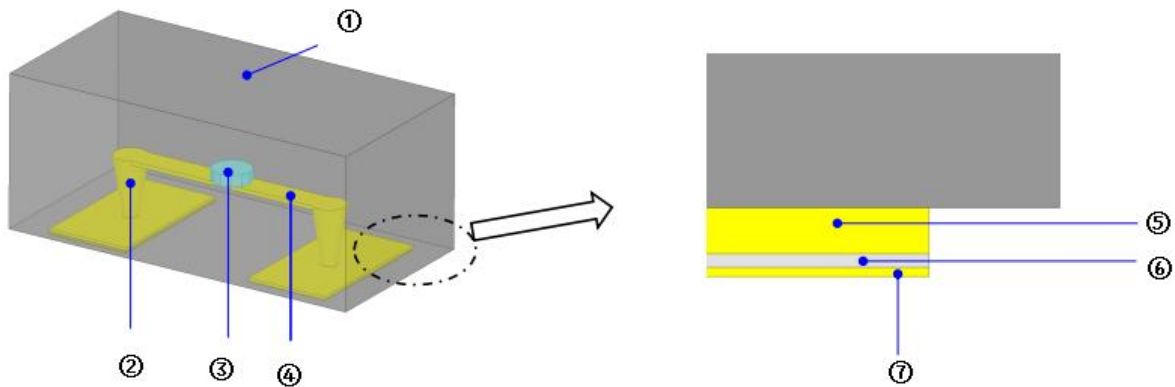
2) Recommended PCB pattern for reflow soldering:



Unit: mm

Size (EIA/JIS)	L	W	H	a	b	A	B	C
0201/0603	0.60±0.10	0.30±0.05	0.30±0.05	0.27±0.05	0.2±0.05	0.30±0.05	0.25±0.05	0.30±0.05
0402/1005	1.00±0.10	0.55±0.10	0.45±0.10	0.50±0.05	0.25±0.05	0.30±0.05	0.50±0.05	0.60±0.05
0603/1608	1.60±0.15	0.80±0.15	0.50±0.10	0.75±0.05	0.5±0.05	0.70±0.05	0.65±0.05	0.95±0.05

■ Structure and Materials



No.	Name	
①	Epoxy resin composite	
②	Connecting electrode (Cu)	
③	ESD absorbent	
④	Internal electrode(Cu)	
⑤	Terminal electrode	Cu
⑥		Ni
⑦		Sn/Au

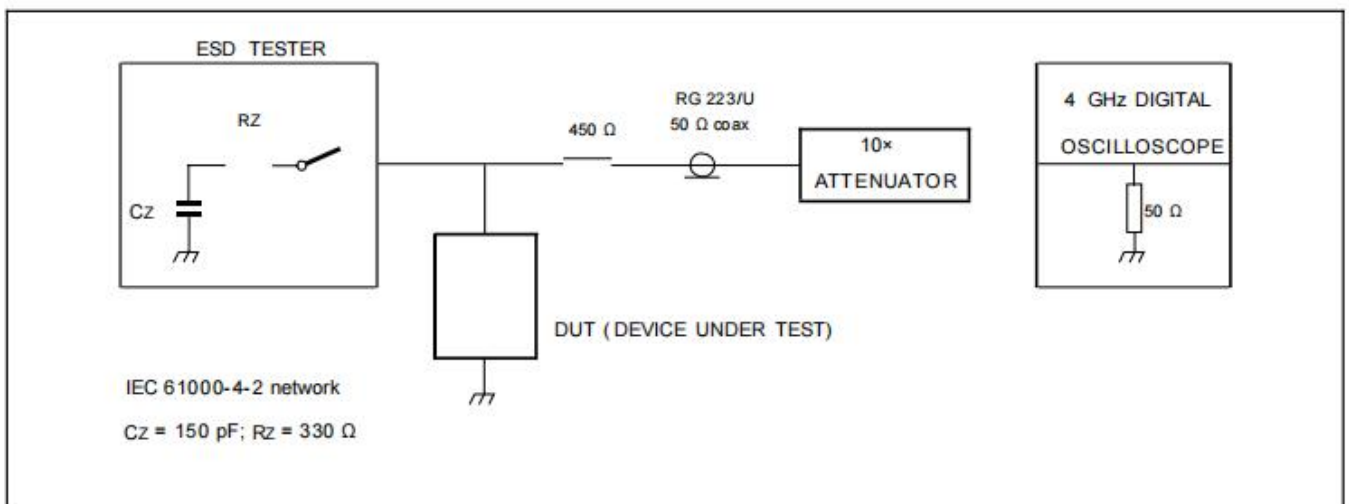
Electrical Characteristics

Part Number	Max. Working voltage	Trigger voltage	Clamping voltage	capacitance	ESD Capability
Test Condition	DC	ESD	ESD	@ 1MHz	Direct Discharge
Units	V _{DC}	V _T	V _c	C	
Symbol	Volts	Volts	Volts	pF	
KESD0201ED5R0C0R05AK000T	5V	350V	35V	0.05pf	8kV, contact
KESD0201ED120C0R05AK000T	12V	350V	35V	0.05pf	8kV, contact
KESD0201ED300C0R05AK000T	30V	350V	35V	0.05pf	8kV, contact
KESD0402ED5R0C0R05AK000T	5V	350V	35V	0.05pf	8kV, contact
KESD0402ED120C0R05AK000T	12V	350V	35V	0.05pf	8kV, contact
KESD0402ED300C0R05AK000T	30V	350V	35V	0.05pf	8kV, contact
KESD0603ED5R0C0R05AK000T	5V	350V	35V	0.05pf	8kV, contact
KESD0603ED120C0R05AK000T	12V	350V	35V	0.05pf	8kV, contact
KESD0603ED300C0R05AK000T	30V	350V	35V	0.05pf	8kV, contact

※ Notes:

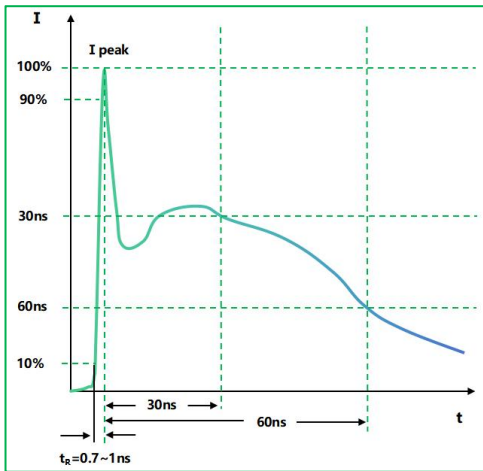
- a. I_L: The Leakage current was measured at DC 3.3V shall be applied on component
- b. V_t: The Trigger voltage was measured at 1mA.
- c. V_c: The clamping voltage was measured at 1A by 8/20μs Pulse.
- d. C_p: The capacitance value was measured at f= 1MHz, V_{RMS}= 0.5V.
- e. I_L: The Leakage current was measured at DC 3.3V shall be applied on component

ESD Clamping Test



Wave Form

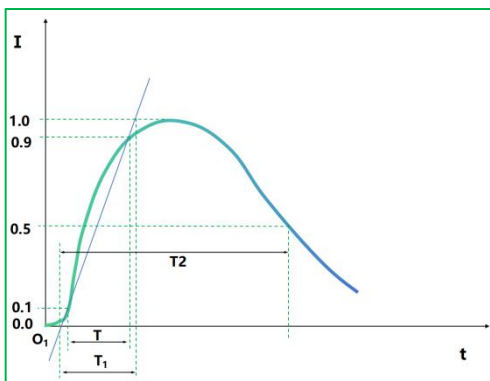
❖ ESD Wave Form



IEC61000-4-2 Standards

SEVERITY LEVEL	AIR DIRCHARGE	DIRECT DISCHARGE
1	2KV	2KV
2	4KV	4KV
3	8KV	6KV
4	15KV	8KV

❖ Surge Wave Form

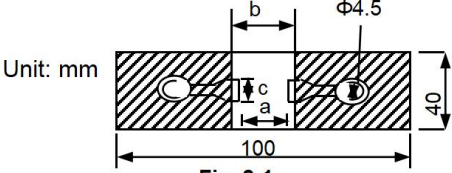
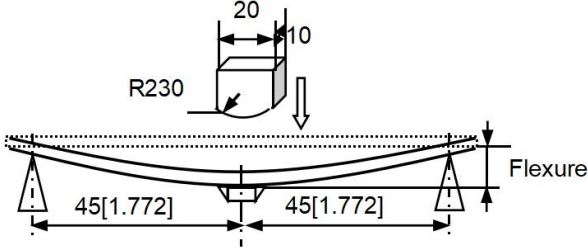
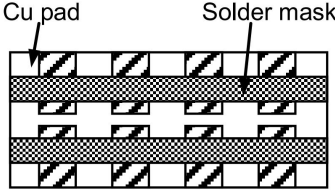


IEC61000-4-5 Standards

SEVERITY LEVEL	T ₁ (=1.25*T)	T ₂
1	10 μ s	1000 μ s
2	8 μ s	20 μ s

Reliability Test

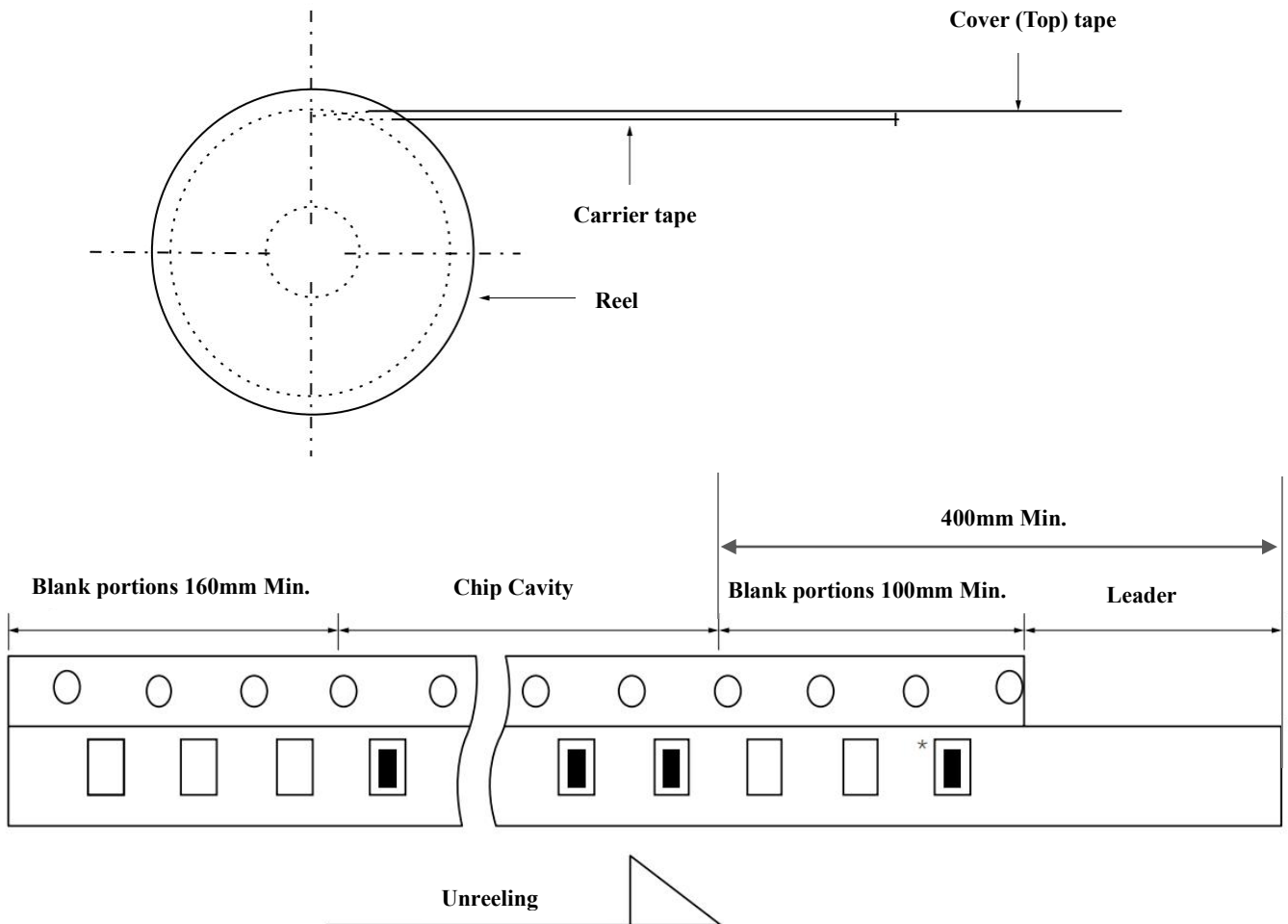
Items	Requirements	Test Methods and Remarks						
Terminal Strength	No removal or split of the termination or other defects shall occur.	Solder the chip to the testing jig (glass epoxy board shown in the following Fig. 1-1) using eutectic solder. Then apply a force in the direction of the arrow. <table border="1" style="margin-top: 10px;"> <thead> <tr> <th>Size (EIA)</th> <th>Force</th> <th>Duration</th> </tr> </thead> <tbody> <tr> <td>0201, 0402, 0603</td> <td>5N</td> <td>10 ± 1s</td> </tr> </tbody> </table>	Size (EIA)	Force	Duration	0201, 0402, 0603	5N	10 ± 1s
	Size (EIA)		Force	Duration				
0201, 0402, 0603	5N	10 ± 1s						
<p style="text-align: center;">Fig.1-1</p>								

Resistance to Flexure	No visible mechanical damage.	Solder the chip to the test jig (glass epoxy board shown in Fig.2-1) using a eutectic solder. Then apply a force in the direction shown in Fig. 2-2.																							
	<p>Unit: mm</p> <table border="1"> <thead> <tr> <th>Size (EIA)</th> <th>a</th> <th>b</th> <th>c</th> </tr> </thead> <tbody> <tr> <td>0201</td> <td>0.25</td> <td>0.3</td> <td>0.3</td> </tr> <tr> <td>0402</td> <td>0.4</td> <td>1.5</td> <td>0.5</td> </tr> <tr> <td>0603</td> <td>1.0</td> <td>3.0</td> <td>1.2</td> </tr> </tbody> </table>  <p>Unit: mm</p> <p>Fig. 2-1</p>		Size (EIA)	a	b	c	0201	0.25	0.3	0.3	0402	0.4	1.5	0.5	0603	1.0	3.0	1.2	<table border="1"> <thead> <tr> <th>Size (EIA)</th> <th>Flexure</th> <th>Pressurizing Speed</th> <th>Duration</th> </tr> </thead> <tbody> <tr> <td>0201、0402、0603</td> <td>2mm</td> <td><0.5mm/s</td> <td>10±1s</td> </tr> </tbody> </table>  <p>Fig.2-2</p>	Size (EIA)	Flexure	Pressurizing Speed	Duration	0201、0402、0603	2mm
Size (EIA)	a	b	c																						
0201	0.25	0.3	0.3																						
0402	0.4	1.5	0.5																						
0603	1.0	3.0	1.2																						
Size (EIA)	Flexure	Pressurizing Speed	Duration																						
0201、0402、0603	2mm	<0.5mm/s	10±1s																						
Vibration	<p>No visible mechanical damage.</p>  <p>Glass Epoxy Board</p> <p>Fig. 3-1</p>	<ul style="list-style-type: none"> ❖ Solder the chip to the testing jig (glass epoxy board shown in Fig.3-1) using eutectic solder. ❖ The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. ❖ The frequency ranging from 10 to 55 Hz and returning to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours). 																							
Solderability	<ul style="list-style-type: none"> ❖ No visible mechanical damage. ❖ Wetting shall exceed 80% coverage. 	<ul style="list-style-type: none"> ❖ Solder temperature: 240±2℃. ❖ Duration: 3 sec. ❖ Solder: Sn/3.0Ag/0.5Cu. ❖ Flux: 25% Resin and 75% ethanol in weight. 																							
Resistance to Soldering Heat	<ul style="list-style-type: none"> ❖ No visible mechanical damage. ❖ Varistor voltage change: within ±10%. 	<ul style="list-style-type: none"> ❖ Solder temperature: 260±3℃ ❖ Duration: 5 sec. ❖ Solder: Sn/3.0Ag/0.5Cu. ❖ Flux: 25% Resin and 75% ethanol in weight. ❖ The chip shall be stabilized at normal condition for 1~2hours before measuring. 																							
Thermal Shock	<ul style="list-style-type: none"> ❖ No visible mechanical damage. ❖ Varistor voltage change: within ±10%. 	<p>After repeating the cycles stated below for specified number of times, leave the part for 1~2 hours, then evaluate its characteristics.</p> <p>Cycle : 5 cycles</p> <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature</th> <th>Period</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Max. Operating Temp.</td> <td>30±3 min</td> </tr> <tr> <td>2</td> <td>Ordinary temp.</td> <td>3 min max.</td> </tr> <tr> <td>3</td> <td>Min. Operating Temp.</td> <td>30±3 min</td> </tr> <tr> <td>4</td> <td>Ordinary temp.</td> <td>3 min max.</td> </tr> </tbody> </table>	Step	Temperature	Period	1	Max. Operating Temp.	30±3 min	2	Ordinary temp.	3 min max.	3	Min. Operating Temp.	30±3 min	4	Ordinary temp.	3 min max.								
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3	Min. Operating Temp.	30±3 min																							
4	Ordinary temp.	3 min max.																							

<p>Resistance to Low Temperature</p>	<ul style="list-style-type: none"> ❖ No visible mechanical damage. ❖ Varistor voltage change: within $\pm 10\%$. 	<ul style="list-style-type: none"> ❖ Temperature: $-40\pm 2^{\circ}\text{C}$ ❖ Duration: 1000+24 hours. ❖ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
<p>Resistance to High Temperature</p>	<ul style="list-style-type: none"> ❖ No visible mechanical damage. ❖ Varistor voltage change: within $\pm 10\%$. 	<ul style="list-style-type: none"> ❖ Temperature: $125\pm 2^{\circ}\text{C}$ ❖ Duration: 1000+24 hours. ❖ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
<p>Damp Heat (Steady States)</p>	<ul style="list-style-type: none"> ❖ No visible mechanical damage. ❖ Varistor voltage change: within $\pm 10\%$. 	<ul style="list-style-type: none"> ❖ Temperature: $40\pm 2^{\circ}\text{C}$ ❖ Humidity: 90% to 95% RH. ❖ Duration: 1000+24 hours. ❖ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
<p>Loading at High Temperature (Life Test)</p>	<ul style="list-style-type: none"> ❖ No visible mechanical damage. ❖ Varistor voltage change: within $\pm 10\%$. 	<ul style="list-style-type: none"> ❖ Temperature: $85\pm 2^{\circ}\text{C}$ ❖ Duration: 1000+24 hours. ❖ Applied current: Max. Permissive Operating Current. ❖ The chip shall be stabilized at normal condition for 1~2 hours before measuring.

■ Packaging

(1) Figure

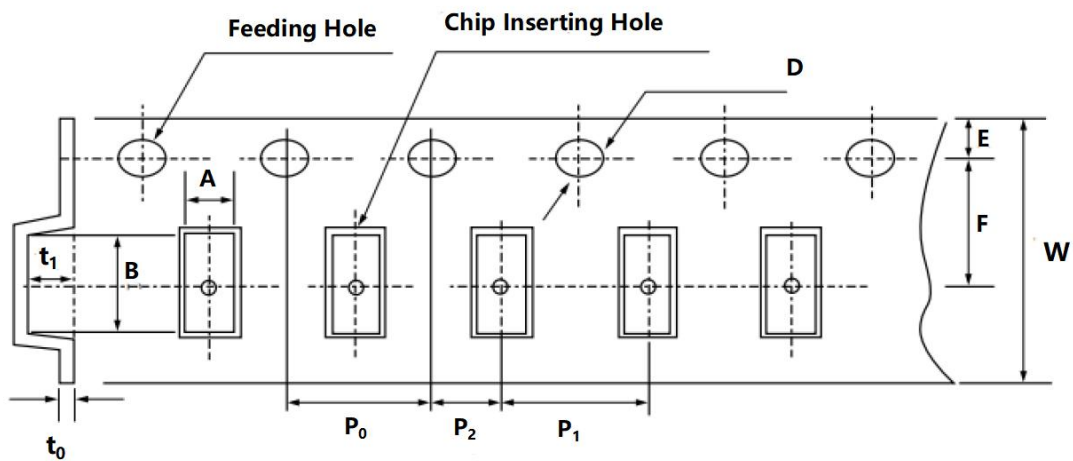


(2) Quantity

Size(EIA)		0201	0402	0603
Taping Type		PAPER	PAPER	PAPER
Quantity	Reel	15K	10K	4K
	Inner Box	15K×10=150K	10K×10=100K	4K×10=40K
	Outer Box	15K×10×6=900K	10K×10×6=600K	4K×10×6=240K

(3) Tape Size

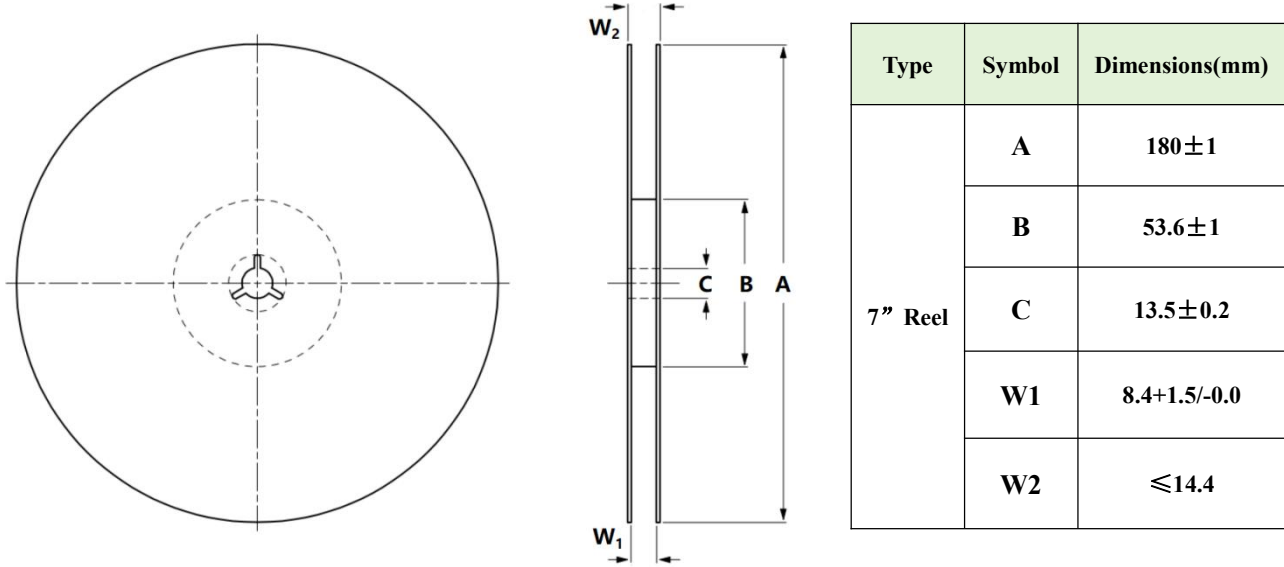
❖ Embossed (Plastic) tape



Unit: mm

Size (EIA)	A	B	W	F	E	P1	P2	P0	D	t
0201	0.38±0.1	0.68±0.10	8.00 ±0.30	3.50 ±0.05	1.75 ±0.10	2.00 ±0.05	2.00 ±0.05	4.00 ±0.10	Φ 1.50 +0.1/-0.03	≤0.5
0402	0.65±0.1	1.15±0.1				2.00 ±0.05				≤0.8
0603	1.0±0.2	1.8±0.2				4.00 ±0.10				≤1.1

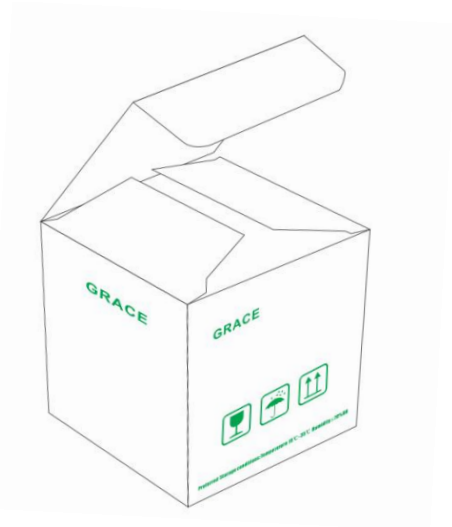
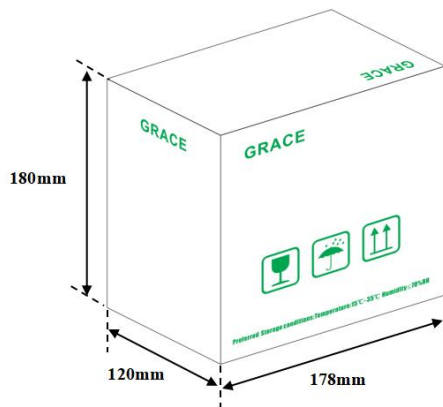
(4) Reel Size



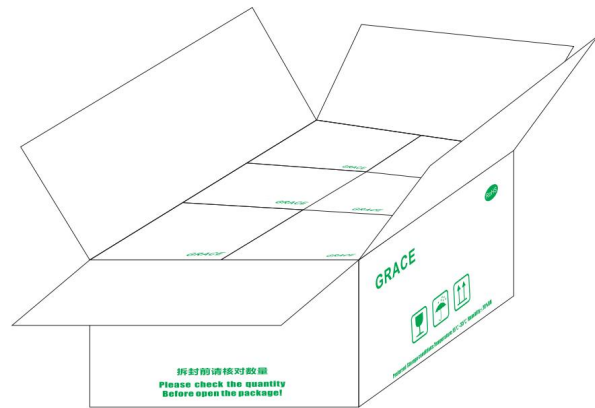
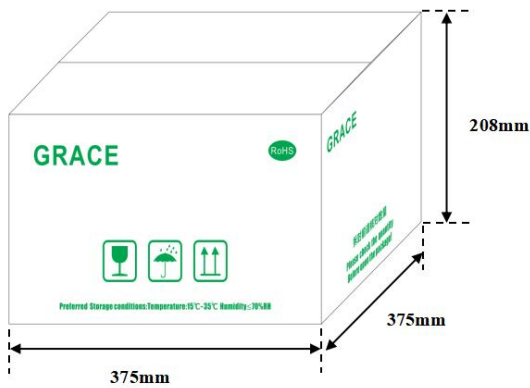
(5) BOX package

Double packaging with the paper type of inner box and outer box.

❖ Inner Box :



❖ Outer Box :



※ Box size specifications for reference.

■ Storage environment

(1) Recommendation for temperature/humidity

- ❖ Even taping and packaging materials are designed to endure a long-term storage, they should be stored with a temperature of -10~40°C and an RH of 0~70% otherwise, too high temperatures or humidity may deteriorate the quality of the chip rapidly.
- ❖ Packaging material may be deformed if packages are stored where they are exposed to heat of direct sunlight.
- ❖ As oxidization is accelerated when relative humidity is above 70%RH, the lower the humidity is, the better the solderability is.
- ❖ As the temperature difference may cause dew condensation during the storage of the chip, it is a must to maintain a temperature control environment.

(2) Shelf Life

- ❖ An allowable storage period should be within 12 months from the outgoing date of delivery in consideration of solderability.
- ❖ As for chips in storage over 12 months, please check solderability before use.

(3) Caution for corrosive environment

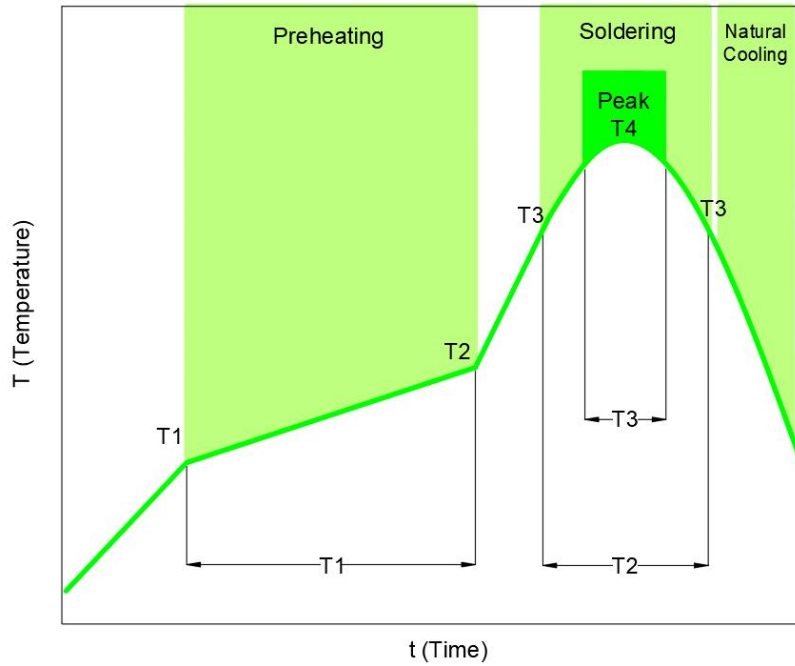
As corrosive gases may deteriorate the solderability of chip outer termination, it is a must to store chip in an environment without gases. chip that is exposed to corrosive gases may cause its quality issues due to the corrosion of plating layers and the penetration of moisture.

■ Process of Mounting and Soldering

(1) Reflow soldering

The reflow soldering temperature conditions are composed of temperature curves of Preheating, Temp. rise, Heating, Peak and Gradual cooling. Large temperature difference inside the chip caused by rapid heat application to the chip may lead to excessive thermal stresses, contributing to the thermal cracks. The Preheating temperature requires controlling with great care so that tombstone phenomenon may be prevented.

Follow the recommended soldering conditions to avoid degradation of performance .



Item	Specification	
	For eutectic mixture solder	For lead-free solder
Preheating temperature	160 ~ 180 °C	150 ~ 180 °C
Solder melting temperature	200 °C	230 °C
Maximum temperature	240° C max.	260 °C max.
Preheating time	100s max.	120s max.
Time to reach higher than the solder melting temperature	30s max.	40s max.
number of possible reflow cycles	2 max.	2 max.

- ※ Pre-heating is necessary for all constituents including the PCB to prevent the mechanical damages on the chip .
The temperature difference between the PCB and the component surface must be kept to the minimum.
 - a. Allowable temperature difference $\Delta T \leq 150 \text{ }^\circ\text{C}$
 - b. Use non-activated flux. (Max. Cl content less than 0.1%)

(2) Recommended Amount of Solder

- ※ Solder thickness 0.15 to 0.2mm

(3) Cleaning

- ❖ In general, cleaning is unnecessary if rosin flux is used.

When acidic flux is used strongly, chlorine in the flux may dissolve into some types of cleaning fluids, thereby affecting the performance of the chip.

This means that the cleansing solution must be carefully selected and should always be new.

❖ Cautions for cleaning

- a. Soldering flux residue may remain on the PC board if cleaned with an inappropriate solvent. This may deteriorate the performance of Varistors, especially insulation resistance.
- b. The chip or solder joint may be cracked with the vibration of PCB, if ultrasonic vibration is too strong during cleaning. Therefore, test should be done for the cleaning equipment and its process before the cleaning in order to avoid damages on the chip, you can refer to the following conditions for cleaning

Ultrasound output	Ultrasound frequency	Cleaning time
20W/liter or less	40kHz or less	5minutes or less

 **Limitation**

Please contact us with usage environment information such as voltage, current, temperature, or other special conditions before using our products for the applications listed below. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below.

If you have any questions regarding this 'Limitation', you should first contact our sales personnel or application engineers.

- ❖ **Aerospace/Aviation equipment 1wheeler, 2wheeler and 3wheeler vehicle**
- ❖ **Automotive of Transportation equipment**
- ❖ **Military equipment**
- ❖ **Atomic energy-related equipment**
- ❖ **Undersea equipment**
- ❖ **Medical equipment**
- ❖ **Disaster prevention/crime prevention equipment**
- ❖ **Power plant control equipment**
- ❖ **Traffic signal equipment**
- ❖ **Data-processing equipment**
- ❖ **Electric heating apparatus, burning equipment**
- ❖ **Safety equipment**
- ❖ **Any other applications with the same as or similar complexity or reliability to the applications**